

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (Use several sheets if necessary)	Attorney Docket Number OH648	Application Number New 09/732,322
	Applicant J. Jensen.	
	Filing Date 12.7.00	Group Art Unit 2128

1-598 U.S. PTO
09/732322
12/07/00

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

RF	M. Kitamura, S. Kakukawa, K. Mori, and T. Tominaka, "An optimal design technique for coil configurations in iron-shielded MRI magnets", IEEE Tran. Magn., vol. 30, no. 4, pp. 2352-2355, 1994.
RF	H. Xu, S. M. Conolly, G. C. Scott, and A. Macovski, "Homogeneous magnet design using Linear programming", IEEE Trans. Magn., vol. 36, no. 2, pp. 476-483, 2000.
RF	J. H. Jensen, "Optimization method for permanent-magnet structures", IEEE Trans. Magn., vol. 35, no. 6, pp. 4465-4472, 1999.
RF	M. W. Garrett, "Thick cylindrical coil systems for strong magnetic fields with field or gradient homogeneities of the 6th to 20th order", J. Appl. Phys., vol. 38, no. 6, pp. 2567-2591, 1967.
EXAMINER:	RUSSELL FREJD DATE CONSIDERED: 6.14.04
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.	



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SHEET 1 OF 1
(REV. 7-80)**LIST OF REFERENCES CITED BY APPLICANT**

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DOCKET NO.: 5986/OH648
APPLICANT: Jens JENSENSERIAL NO: 09/732322
FILING DATE: December 7, 2000
CONFIRMATION NO: 1566**U.S. PATENT DOCUMENTS**

<u>*EXAMINER</u> <u>INITIALS</u>	<u>DOCUMENT</u> <u>NUMBER</u>	<u>DATE</u>	<u>NAME</u>	<u>CLASS</u>	<u>SUBCLASS</u>	<u>FILING DATE</u>
RF	1. 6,255,929 B1	07/03/01	Xu et al.	335	299	10/26/00

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<u>*EXAMINER</u> <u>INITIALS</u>	<u>DOCUMENT</u> <u>NUMBER</u>	<u>DATE</u>	<u>COUNTRY</u>	<u>CLASS</u>	<u>SUBCLASS</u>	<u>TRANSLATION</u> <u>YES</u> <u>NO</u>
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OTHER REFERENCES**(INCLUDING AUTHOR, TITLE DATE, PERTINENT PAGES, ETC.)***EXAMINER
INITIALS

RF

2. S. Kakugawa et al., A Study on Optimal Coil Configurations in a Split-Type Superconducting MRI Magnet, (1999) IEEE Vol.9, No. 2, pp. 366-367.

EXAMINER:

Russell FREID

DATE CONSIDERED:

6.14.04

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SHEET 1 OF 1
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DOCKET NO.: 5986/0H648
APPLICANT: Jens JensenSERIAL NO: 09/732,322
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<u>*EXAMINER INITIALS</u>	<u>DOCUMENT NUMBER</u>	<u>DATE</u>	<u>NAME</u>	<u>CLASS</u>	<u>SUBCLASS</u>	<u>FILING DATE</u>
RF	1. 5,664,568	09/09/97	Srinivasan et al.	128	653.2	08/08/95
RF	2. 5,706,813	01/13/98	Filler et al.	128	653.5	03/18/97

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<u>*EXAMINER INITIALS</u>	<u>DOCUMENT NUMBER</u>	<u>DATE</u>	<u>COUNTRY</u>	<u>CLASS</u>	<u>SUBCLASS</u>	<u>TRANSLATION YES NO</u>
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